

<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/051,267	TANAKA ET AL.
	Examiner	Art Unit
	Thien F. Tran	2811

ORIGINAL				CROSS REFERENCE(S)								
CLASS	SUBCLASS	CLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)								
257	59	257	66	70	72	75						
INTERNATIONAL CLASSIFICATION												
H	0	1	L	29/04								
				31/036								
				31/0376								
				31/20								
				/								
				Thien F. Tran				Total Claims Allowed: 4				
(Assistant Examiner) (Date)				Thien F. Tran 03/16/2005				O.G. Print Claim(s)		O.G. Print Fig.		
Yolanda Polino 3/21/05 (Legal Instruments Examiner) (Date)				(Primary Examiner) (Date)				1		1		

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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